



# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

## General Description

The MAX6846–MAX6849 are a family of ultra-low-power battery monitors with integrated microprocessor ( $\mu$ P) supervisors. The user-adjustable battery monitors are offered with single or dual low-battery output options that can be used to signal when the battery is OK (enabling full system operation), when the battery is low (for low-power system operation), and when the battery is dead (to disable system operation). These devices also have an independent  $\mu$ P supervisor that monitors  $V_{CC}$  and provides an active-low reset output. A manual reset function is available to reset the  $\mu$ P with a pushbutton.

The MAX6846–MAX6849 are ideal for single-cell lithium-ion (Li+) or multicell alkaline/NiCd/NiMH applications. When the battery voltage drops below each adjusted low threshold, the low-battery outputs are asserted to alert the system. When the voltage rises above the adjusted high thresholds, the outputs are deasserted after a 150ms minimum timeout period, ensuring the voltages have stabilized before power circuitry is activated or providing microprocessor reset timing.

These devices have user-adjustable battery threshold voltages, providing a wide hysteresis range to prevent chattering that can result due to battery recovery after load removal. Single low-battery outputs are supplied by the MAX6846/MAX6847 and dual low-battery outputs are supplied by the MAX6848/MAX6849. All battery monitors have open-drain low-battery outputs.

The MAX6846–MAX6849 monitor system voltages ( $V_{CC}$ ) from 1.8V to 3.3V with seven fixed reset threshold options. Each device is offered with two minimum reset timeout periods of 150ms or 1200ms. The MAX6846/MAX6848 are offered with an open-drain  $\overline{\text{RESET}}$  output and the MAX6847/MAX6849 are offered with a push-pull  $\overline{\text{RESET}}$  output.

The MAX6846–MAX6849 are offered in a SOT23 package and are fully specified over a  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  temperature range.

## Applications

Battery-Powered Systems (Single-Cell Li+ or Multicell NiMH, NiCd, Alkaline)  
Cell Phones/Cordless Phones  
Portable Medical Devices  
Digital Cameras  
Pagers  
PDAs  
MP3 Players  
Electronic Toys

## Features

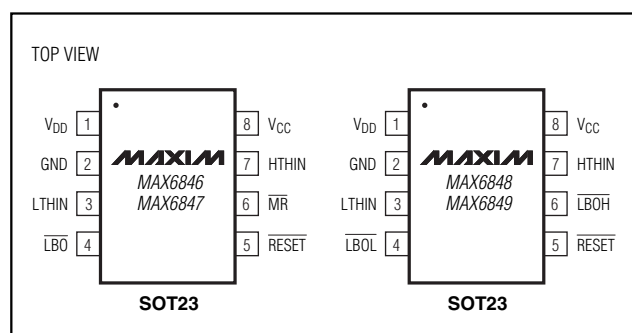
- ◆ User-Adjustable Thresholds for Monitoring Single-Cell Li+ or Multicell Alkaline/NiCd/NiMH Applications
- ◆ Single and Dual Low-Battery Output Options
- ◆ Independent  $\mu$ P Reset with Manual Reset
- ◆ Factory-Set Reset Thresholds for Monitoring 1.8V to 3.3V Systems
- ◆ Available with 150ms (min) or 1.2s (min)  $V_{CC}$  Reset Timeout Period Options
- ◆ 150ms (min)  $\overline{\text{LBO}}$  Timeout Period
- ◆ Immune to Short-Battery Voltage Transients
- ◆ Low Current (2.5 $\mu$ A, typ at 3.6V)
- ◆  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  Operating Temperature Range
- ◆ Small 8-Pin SOT23 Packages

## Ordering Information

PART	TEMP RANGE	PIN-PACKAGE
MAX6846KA_D_-T	$-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$	8 SOT23-8
MAX6847KA_D_-T	$-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$	8 SOT23-8
MAX6848KA_D_-T	$-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$	8 SOT23-8
MAX6849KA_D_-T	$-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$	8 SOT23-8

**Note:** The first “\_” is the  $V_{CC}$  reset threshold level, suffix found in Table 1. The “\_” after the D is a placeholder for the reset timeout period suffix found in Table 2. All devices are available in tape-and-reel only. There is a 2500 piece minimum order increment for standard versions (see Standard Versions table). Sample stock is typically held on standard versions only. Non-standard versions require a minimum order increment of 10,000 pieces. Contact factory for availability.

## Pin Configurations



# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu P$ Reset

## ABSOLUTE MAXIMUM RATINGS

$V_{DD}$ ,  $V_{CC}$  to GND ..... -0.3V to +6V\*  
 Open-Drain  $\overline{LBO}$ ,  $\overline{LBOH}$ ,  $\overline{LBOL}$  to GND ..... -0.3V to +6V\*  
 Open-Drain RESET to GND ..... -0.3V to +6V\*  
 Push-Pull RESET to GND ..... -0.3V to ( $V_{CC} + 0.3V$ )  
 HTHIN, LTHIN to GND ..... -0.3V to ( $V_{DD} + 0.3V$ )  
 MR to GND ..... -0.3V to ( $V_{CC} + 0.3V$ )  
 Input/Output Current, All Pins ..... 20mA

\*Applying 7V for a duration of 1ms does not damage the device.

Continuous Power Dissipation ( $T_A = +70^\circ\text{C}$ )  
 8-Pin SOT23 (derate 8.9mW/ $^\circ\text{C}$  above  $+70^\circ\text{C}$ ) ..... 714mW  
 Operating Temperature Range .....  $-40^\circ\text{C}$  to  $+85^\circ\text{C}$   
 Junction Temperature .....  $+150^\circ\text{C}$   
 Storage Temperature Range .....  $-65^\circ\text{C}$  to  $+150^\circ\text{C}$   
 Lead Temperature (soldering, 10s) .....  $+300^\circ\text{C}$

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ELECTRICAL CHARACTERISTICS

( $V_{DD} = 1.6V$  to  $5.5V$ ,  $V_{CC} = 1.2V$  to  $5.5V$ ,  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ , unless otherwise specified. Typical values are at  $T_A = +25^\circ\text{C}$ .) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
$V_{DD}$ Operating Voltage Range	$V_{DD}$		1.6		5.5	V
$V_{CC}$ Operating Voltage Range	$V_{CC}$	$T_A = 0^\circ\text{C}$ to $+85^\circ\text{C}$	1.0		5.5	V
		$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	1.2		5.5	
$V_{CC} + V_{DD}$ Supply Current	$I_{CC} + I_{DD}$	$V_{DD} = 3.6V$ , $V_{CC} = 3.3V$ , no load (Note 2)		2.5	7	$\mu\text{A}$
<b>MAX6846/MAX6847 <math>V_{DD}</math> THRESHOLDS</b>						
HTHIN Threshold	$V_{HTH}$	HTHIN rising, $\overline{LBO}$ is deasserted when HTHIN rises above $V_{HTH}$	600	615	630	mV
LTHIN Threshold	$V_{LTH}$	LTHIN falling, $\overline{LBO}$ is asserted when LTHIN falls below $V_{LTH}$	600	615	630	mV
<b>MAX6848/MAX6849 <math>V_{DD}</math> THRESHOLDS</b>						
HTHIN+ Threshold	$V_{HTH+}$	HTHIN rising, $\overline{LBOH}$ is deasserted when HTHIN rises above $V_{HTH+}$	600	615	630	mV
HTHIN- Threshold	$V_{HTH-}$	HTHIN falling, $\overline{LBOH}$ is asserted when HTHIN falls below $V_{HTH-}$	567	582	597	mV
LTHIN+ Threshold	$V_{LTH+}$	LTHIN rising, $\overline{LBOL}$ is deasserted when LTHIN rises above $V_{LTH+}$	600	615	630	mV
LTHIN- Threshold	$V_{LTH-}$	LTHIN falling, $\overline{LBOL}$ is asserted when LTHIN falls below $V_{LTH-}$	567	582	597	mV
<b>MAX6846-MAX6849</b>						
HTHIN/LTHIN Leakage Current	$I_{LKG}$	$V_{HTHIN}$ or $V_{LTHIN} \geq 400\text{mV}$			20	nA
$\overline{LBO}$ , $\overline{LBOL}$ , $\overline{LBOH}$ Timeout Period	$t_{LBOP}$	HTHIN/LTHIN rising above threshold	150	225	300	ms
$\overline{LBO}$ , $\overline{LBOL}$ , $\overline{LBOH}$ Delay Time	$t_{LBOD}$	HTHIN/LTHIN falling below threshold		100		$\mu\text{s}$
$\overline{LBO}$ , $\overline{LBOL}$ , $\overline{LBOH}$ Output Low	$V_{OL}$	( $V_{DD}$ or $V_{CC}$ ) $\geq 1.2V$ , $I_{SINK} = 50\mu\text{A}$ , asserted low			0.3	V
		( $V_{DD}$ or $V_{CC}$ ) $\geq 1.6V$ , $I_{SINK} = 100\mu\text{A}$ , asserted low			0.3	
		( $V_{DD}$ or $V_{CC}$ ) $\geq 2.7V$ , $I_{SINK} = 1.2\text{mA}$ , asserted low			0.3	
		( $V_{DD}$ or $V_{CC}$ ) $\geq 4.5V$ , $I_{SINK} = 3.2\text{mA}$ , asserted low			0.3	

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

MAX6846-MAX6849

## ELECTRICAL CHARACTERISTICS (continued)

( $V_{DD} = 1.6V$  to  $5.5V$ ,  $V_{CC} = 1.2V$  to  $5.5V$ ,  $T_A = -40^{\circ}C$  to  $+85^{\circ}C$ , unless otherwise specified. Typical values are at  $T_A = +25^{\circ}C$ .) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
$\overline{LBO}$ , $\overline{LBOL}$ , $\overline{LBOH}$ Output Open-Drain Leakage Current		Output deasserted			500	nA
$V_{CC}$ Reset Threshold	$V_{TH}$	MAX68_ _ _ _ T	3.000	3.075	3.150	V
		MAX68_ _ _ _ S	2.850	2.925	3.000	
		MAX68_ _ _ _ R	2.550	2.625	2.700	
		MAX68_ _ _ _ Z	2.250	2.313	2.375	
		MAX68_ _ _ _ Y	2.125	2.188	2.250	
		MAX68_ _ _ _ W	1.620	1.665	1.710	
		MAX68_ _ _ _ V	1.530	1.575	1.620	
$V_{CC}$ Reset Hysteresis			0.3			%
$V_{CC}$ to $\overline{RESET}$ Delay	$t_{RD}$	$V_{CC}$ falling at 10mV/ $\mu$ s from ( $V_{TH}$ + 100mV) to ( $V_{TH}$ - 100mV)	50			$\mu$ s
$V_{CC}$ to $\overline{RESET}$ Timeout Period	$t_{RP}$	MAX68_ _ _ _ _ D3	150	225	300	ms
		MAX68_ _ _ _ _ D7	1200	1800	2400	
$\overline{MR}$ Input Voltage	$V_{IL}$		0.3 x $V_{CC}$			V
	$V_{IH}$		0.7 x $V_{CC}$			
$\overline{MR}$ Minimum Pulse Width	$t_{MPW}$		1			$\mu$ s
$\overline{MR}$ Glitch Rejection			100			ns
$\overline{MR}$ to $\overline{RESET}$ Delay			200			ns
$\overline{MR}$ Reset Timeout Period	$t_{MRP}$		150	225	300	ms
$\overline{MR}$ Pullup Resistance		$\overline{MR}$ to $V_{CC}$	750	1500	2250	$\Omega$
$\overline{MR}$ Rising Debounce Period	$t_{DEB}$	(Note 3)	150	225	300	ms
$\overline{RESET}$ Output High (Push-Pull)	$V_{OH}$	$V_{CC} \geq 1.53V$ , $I_{SOURCE} = 100\mu A$ , $\overline{RESET}$ deasserted	0.8 x $V_{CC}$			V
		$V_{CC} \geq 2.55V$ , $I_{SOURCE} = 500\mu A$ , $\overline{RESET}$ deasserted	0.8 x $V_{CC}$			
$\overline{RESET}$ Output Low	$V_{OL}$	$V_{CC} \geq 1.0V$ , $I_{SINK} = 50\mu A$ , $\overline{RESET}$ asserted	0.3			V
		$V_{CC} \geq 1.2V$ , $I_{SINK} = 100\mu A$ , $\overline{RESET}$ asserted	0.3			
		$V_{CC} \geq 2.12V$ , $I_{SINK} = 1.2mA$ , $\overline{RESET}$ asserted	0.3			
$\overline{RESET}$ Output Leakage Current (Open Drain)		$\overline{RESET}$ deasserted			500	nA

**Note 1:** Production testing done at  $T_A = +25^{\circ}C$ ; limits over temperature guaranteed by design only.

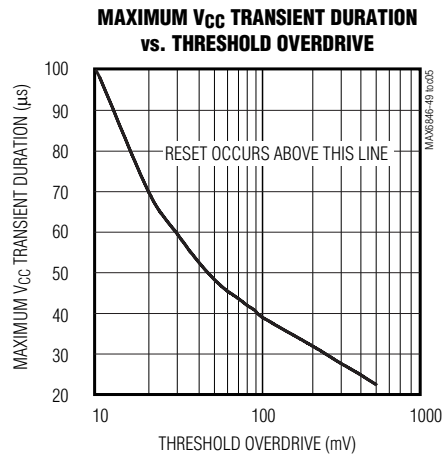
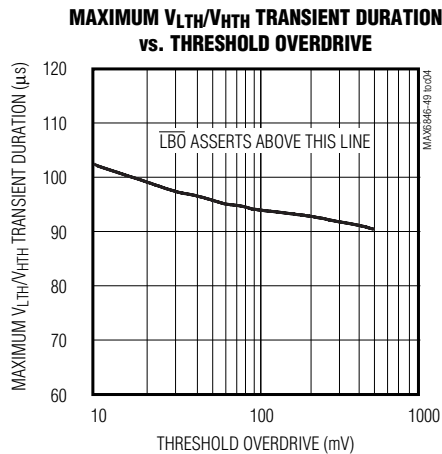
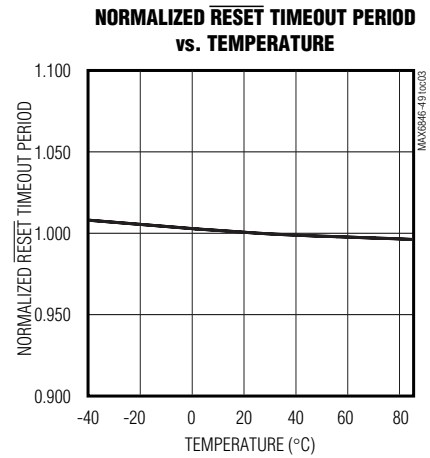
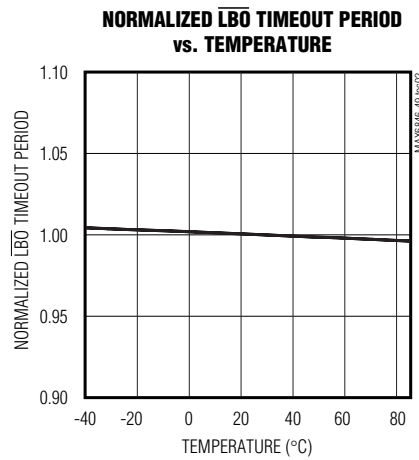
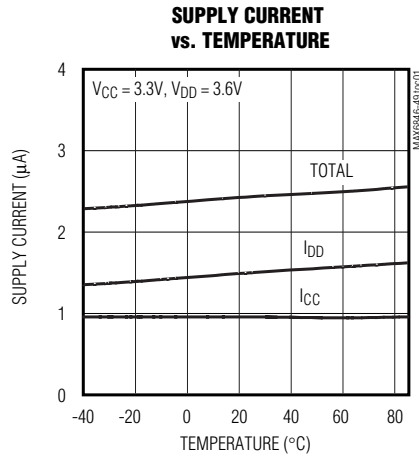
**Note 2:** The device is powered up by the highest voltage between  $V_{DD}$  and  $V_{CC}$ .

**Note 3:**  $\overline{MR}$  input ignores falling input pulses, which occur within the  $\overline{MR}$  debounce period ( $t_{DEB}$ ) after a valid  $\overline{MR}$  reset assertion. This prevents invalid reset assertion due to switch bounce.

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu P$ Reset

## Typical Operating Characteristics

( $V_{DD} = 3.6V$ ,  $V_{CC} = 3.3V$ , unless otherwise specified. Typical values are at  $T_A = +25^\circ C$ .)

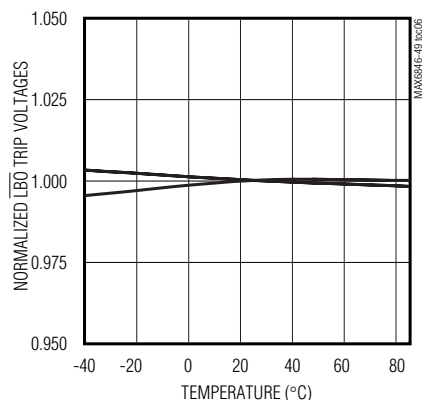


# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

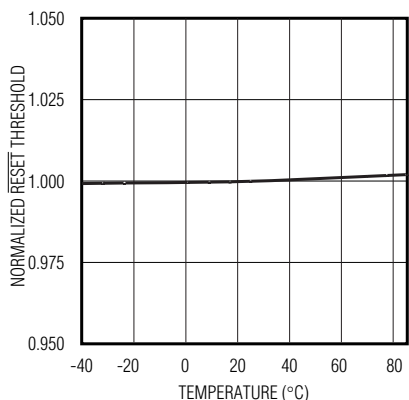
## Typical Operating Characteristics (continued)

( $V_{DD} = 3.6V$ ,  $V_{CC} = 3.3V$ , unless otherwise specified. Typical values are at  $T_A = +25^\circ C$ .)

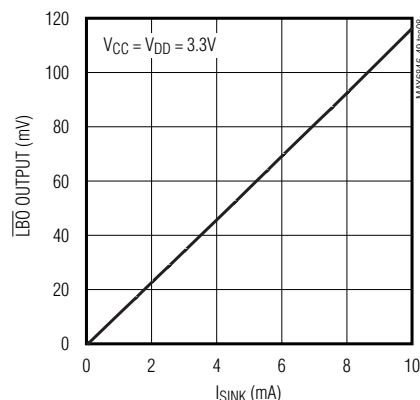
**NORMALIZED UPPER AND LOWER  $\overline{LBO}$  TRIP VOLTAGES vs. TEMPERATURE**



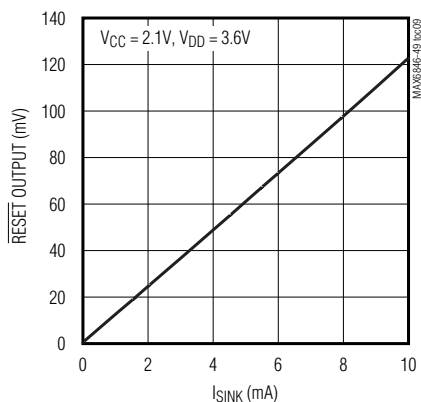
**NORMALIZED RESET THRESHOLD vs. TEMPERATURE**



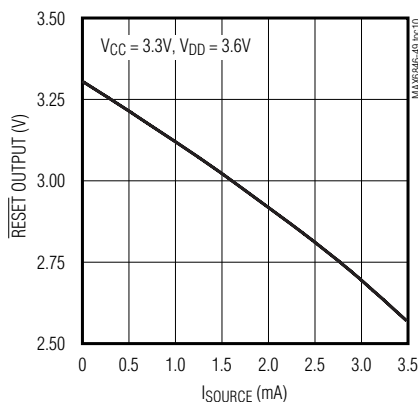
**$\overline{LBO}$  OUTPUT vs. SINK CURRENT**



**RESET OUTPUT vs. SINK CURRENT**



**RESET OUTPUT vs. SOURCE CURRENT**



MAX6846-MAX6849

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

## Pin Description

PIN		NAME	FUNCTION
MAX6846/MAX6847	MAX6848/MAX6849		
1	1	V <sub>DD</sub>	V <sub>DD</sub> Supply. Device power supply if V <sub>DD</sub> is greater than V <sub>CC</sub> .
2	2	GND	Ground
3	3	LTHIN	LTH Threshold Monitor Input. A resistor-divider network sets the low threshold associated with $\overline{\text{LBO}}_{\text{L}}$ and $\overline{\text{LBO}}_{\text{H}}$ .
4	—	$\overline{\text{LBO}}$	Low-Battery Output, Active-Low, Open-Drain. $\overline{\text{LBO}}$ is asserted when LTHIN drops below the V <sub>LTH</sub> specification and remains asserted until HTHIN rises above the V <sub>HTH</sub> specification for at least 150ms.
5	5	$\overline{\text{RESET}}$	Reset Output, Active-Low, Push-Pull, or Open-Drain. $\overline{\text{RESET}}$ goes from high to low when the V <sub>CC</sub> input drops below the selected reset threshold and remains low for the V <sub>CC</sub> reset timeout period after V <sub>CC</sub> exceeds the reset threshold. $\overline{\text{RESET}}$ is one-shot edge-trigger pulsed low for the $\overline{\text{MR}}$ reset timeout period when the $\overline{\text{MR}}$ input is pulled low. $\overline{\text{RESET}}$ is an open-drain output for the MAX6846/MAX6848, and a push-pull output for the MAX6847/MAX6849. The push-pull outputs are referenced to V <sub>CC</sub> . $\overline{\text{RESET}}$ is guaranteed to be in the correct logic state for V <sub>DD</sub> or V <sub>CC</sub> $\geq$ 10V.
6	—	$\overline{\text{MR}}$	Manual Reset Input, Active-Low, Internal 1.5k $\Omega$ Pullup to V <sub>CC</sub> . Pull $\overline{\text{MR}}$ low to assert a one-shot reset output pulse for the $\overline{\text{MR}}$ reset timeout period. Leave unconnected or connect to V <sub>CC</sub> if unused. The $\overline{\text{MR}}$ input is debounced for $\overline{\text{MR}}$ rising edges to prevent false reset events.
7	7	HTHIN	HTH Threshold Monitor Input. A resistor-divider network sets the high threshold associated with $\overline{\text{LBOH}}$ and $\overline{\text{LBO}}$ .
8	8	V <sub>CC</sub>	V <sub>CC</sub> Voltage Input. Input for V <sub>CC</sub> reset threshold monitor and device power supply if V <sub>CC</sub> is greater than V <sub>DD</sub> .
—	6	$\overline{\text{LBOH}}$	Low-Battery Output High, Active-Low, Open-Drain. $\overline{\text{LBOH}}$ is asserted when HTHIN drops below the V <sub>HTH-</sub> specification. $\overline{\text{LBOH}}$ is deasserted when HTHIN rises above the V <sub>HTH+</sub> specification for at least 150ms.
—	4	$\overline{\text{LBOL}}$	Low-Battery Output Low, Active-Low, Open-Drain. $\overline{\text{LBOL}}$ is asserted when LTHIN drops below the V <sub>LTH-</sub> specification. $\overline{\text{LBOL}}$ is deasserted when LTHIN rises above the V <sub>LTH+</sub> specification for at least 150ms.

## Detailed Description

The MAX6846-MAX6849 family is available with several monitoring options. The MAX6846/MAX6847 have single low-battery outputs and the MAX6848/MAX6849 have dual low-battery outputs (see Figures 1a and 1b).

The MAX6846-MAX6849 combine a 615mV reference with two comparators, logic, and timing circuitry to provide the user with information about the charge state of the power-supply batteries. The MAX6848/MAX6849 monitor separate high-voltage and low-voltage thresholds to determine battery status. The output(s) can be used to signal when the battery is charged, when the battery is low, and when the battery is empty. User-

adjustable thresholds are ideal for monitoring single-cell Li+ or multicell alkaline/NiCd/NiMH power supplies.

When the power-supply voltage drops below the specified low threshold, the low-battery output asserts. When the voltage rises above the specified high threshold following a 150ms (min) timeout period, the low-battery output is deasserted. This ensures the supply voltage has stabilized before power-converter or microprocessor activity is enabled.

These devices also have an independent  $\mu$ P supervisor that monitors V<sub>CC</sub> and provides an active-low reset output. A manual reset function is available to allow the user to reset the  $\mu$ P with a pushbutton.

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

MAX6846-MAX6849

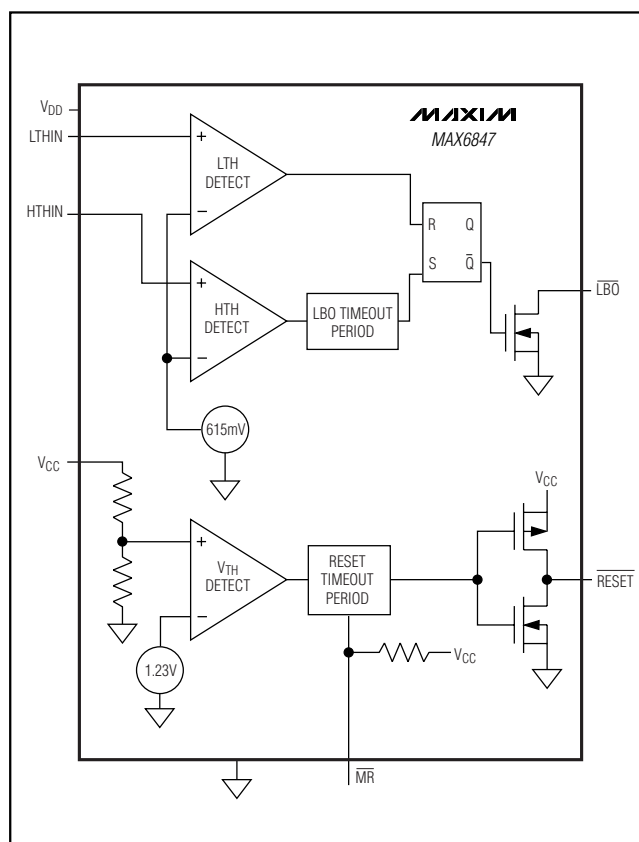


Figure 1a. MAX6847 Functional Diagram

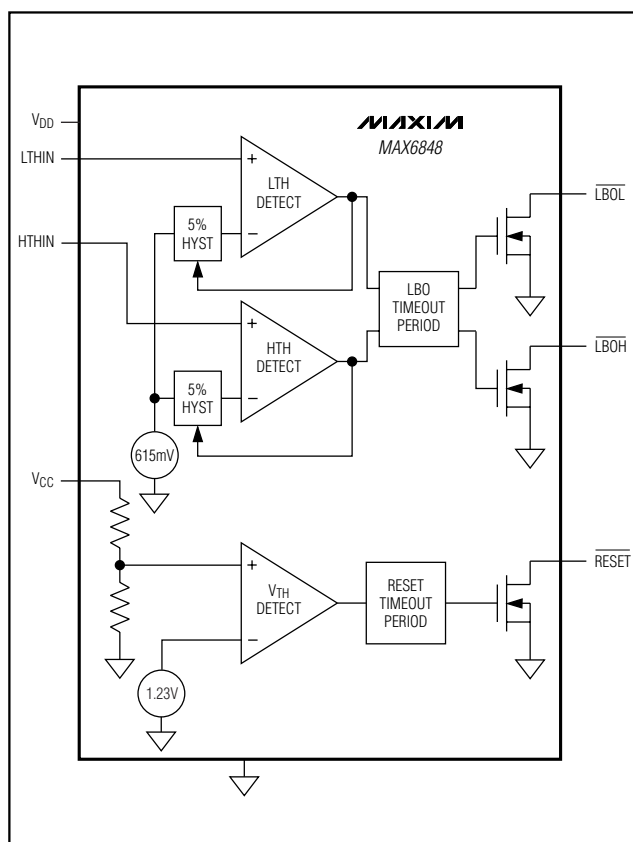


Figure 1b. MAX6848 Functional Diagram

## Low-Battery Output

The low-battery outputs are available in active-low ( $\overline{\text{LBO}}$ ,  $\overline{\text{LBOL}}$ ,  $\overline{\text{LBOH}}$ ), open-drain configurations. The low-battery outputs can be pulled to a voltage independent of  $V_{CC}$  or  $V_{DD}$ , up to 5.5V. This allows the device to monitor and operate from direct battery voltage while interfacing to higher voltage microprocessors.

The MAX6846/MAX6847 single-output voltage monitors provide a single low-battery output,  $\overline{\text{LBO}}$ .  $\overline{\text{LBO}}$  asserts when  $\text{LTHIN}$  drops below  $V_{LTH}$  and remains asserted for at least 150ms after  $\text{HTHIN}$  rises above  $V_{HTH}$  (see Figure 2). The MAX6848/MAX6849 dual-output voltage monitors provide two low-battery outputs:  $\overline{\text{LBOL}}$  and  $\overline{\text{LBOH}}$ .  $\overline{\text{LBOH}}$  asserts when  $\text{HTHIN}$  drops below  $V_{HTH}$  and remains asserted for at least 150ms after  $\text{HTHIN}$

rises above  $V_{HTH+}$ .  $\overline{\text{LBOL}}$  asserts when  $\text{LTHIN}$  drops below  $V_{LTH-}$  and remains asserted for at least 150ms after  $\text{LTHIN}$  rises above  $V_{LTH+}$  (see Figure 3). For fast-rising  $V_{DD}$  input, the  $\overline{\text{LBOL}}$  timeout period must complete before the  $\overline{\text{LBOH}}$  timeout period begins.

## Reset Output

The MAX6846-MAX6849 provide an active-low reset output ( $\overline{\text{RESET}}$ ).  $\overline{\text{RESET}}$  is asserted when the voltage at  $V_{CC}$  falls below the reset threshold level. Reset remains asserted for the reset timeout period after  $V_{CC}$  exceeds the threshold. If  $V_{CC}$  goes below the reset threshold before the reset timeout period is completed, the internal timer restarts (see Figure 4). The MAX6846/MAX6848 have open-drain reset outputs, while the MAX6847/MAX6849 have push-pull reset outputs.

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu P$ Reset

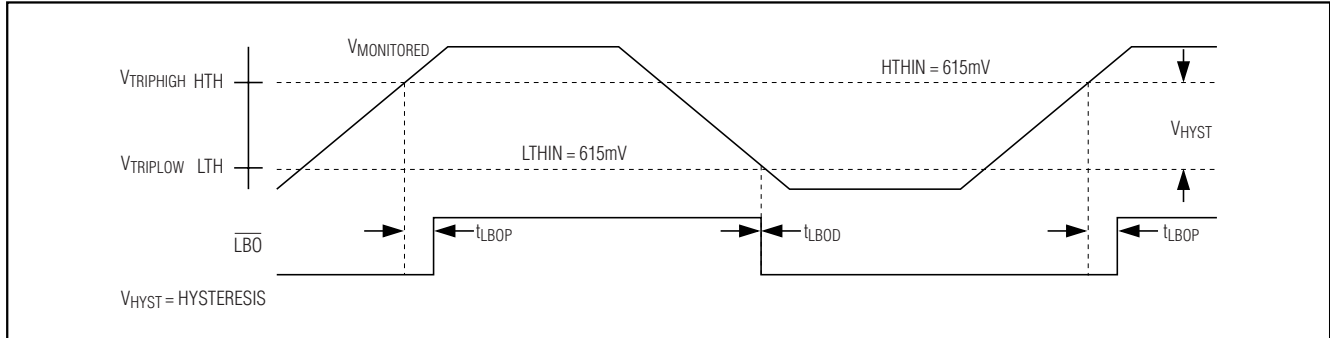


Figure 2. Single Low-Battery Output Timing

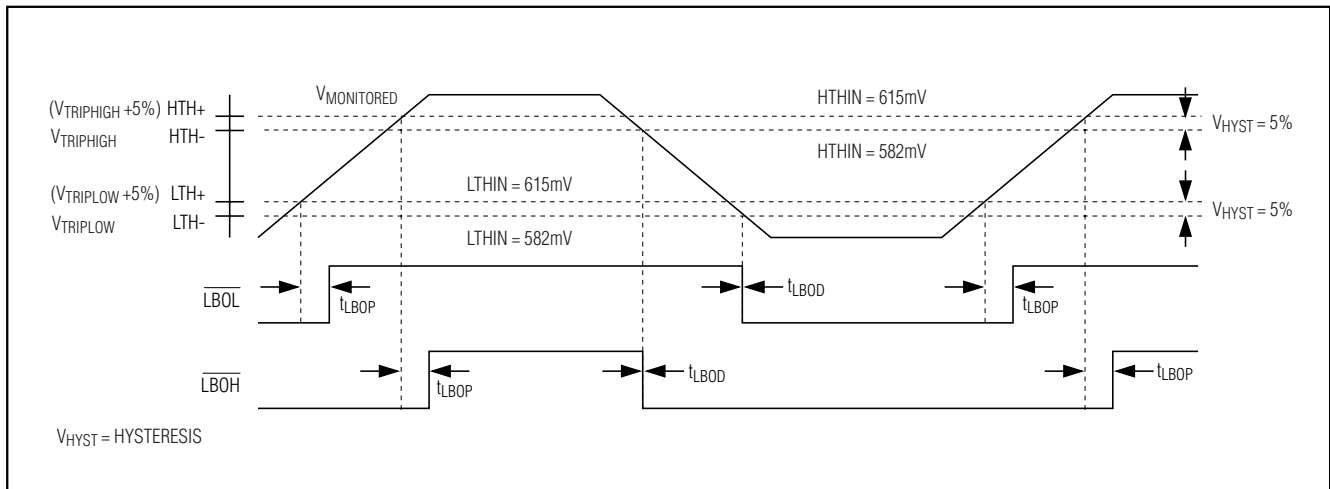


Figure 3. Dual Low-Battery Output Timing

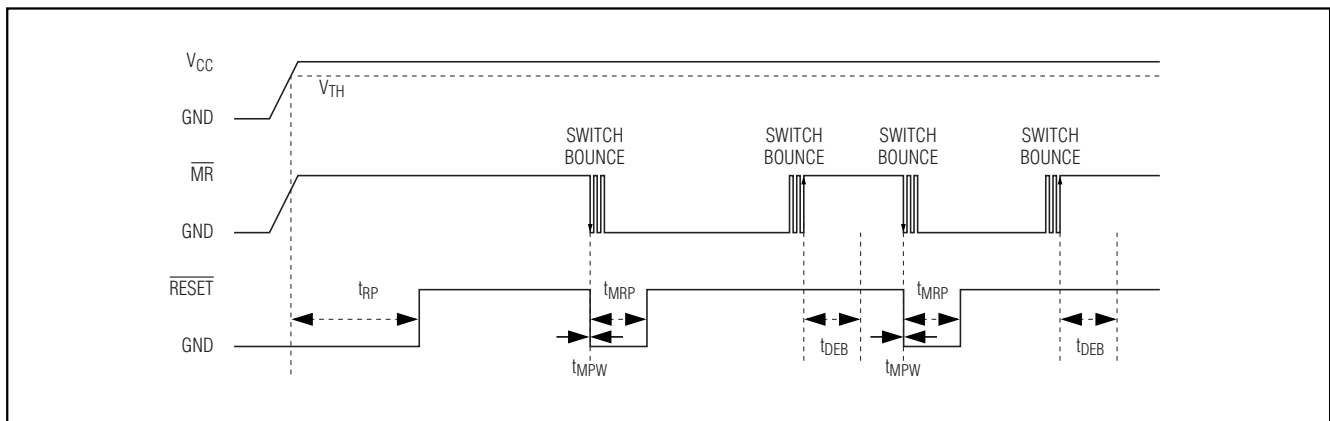


Figure 4. RESET Timing Diagram



# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

## Manual Reset

Many microprocessor-based products require manual reset capability, allowing the operator, a test technician, or external logic circuitry to initiate a reset while the monitored supplies remain above their reset thresholds. These devices have a dedicated active-low  $\overline{\text{MR}}$  pin. When  $\overline{\text{MR}}$  is pulled low,  $\overline{\text{RESET}}$  asserts a one-shot low pulse for the  $\overline{\text{MR}}$  reset timeout period. The  $\overline{\text{MR}}$  input has an internal  $1.5\text{k}\Omega$  pullup resistor to  $V_{\text{CC}}$  and can be left unconnected if not used.  $\overline{\text{MR}}$  can be driven with CMOS-logic levels, open-drain/open-collector outputs, or a momentary pushbutton switch to GND (the MR function is internally debounced for the  $t_{\text{DEB}}$  timeout period) to create a manual reset function. If  $\overline{\text{MR}}$  is driven from long cables, or if the device is used in a noisy environment, connect a  $0.1\mu\text{F}$  capacitor from  $\overline{\text{MR}}$  to GND to provide additional noise immunity (see Figure 4).

## Hysteresis

Hysteresis increases the comparator's noise margin by increasing the upper threshold or decreasing the lower threshold. The hysteresis prevents the output from oscillating (chattering) when monitor input is near the low-battery threshold. This is especially important for applications where the load on the battery creates significant fluctuations in battery voltages (see Figures 2 and 3).

For the MAX6846/MAX6847, hysteresis is set using three external resistors (see Figure 5). The MAX6848/MAX6849 have dual, low-battery input levels. Each input level has a 5% (typ) hysteresis.

## Applications Information

### Resistor-Value Selection (Programming the Adjustable Thresholds)

#### MAX6846/MAX6847

$$\begin{aligned} V_{\text{LTH}} &= V_{\text{HTH}} = 615\text{mV} \\ V_{\text{TRIPLOW}} &= V_{\text{LTH}} \times \left( \frac{R1 + R2 + R3}{R2 + R3} \right) \\ V_{\text{TRIPHIGH}} &= V_{\text{HTH}} \times \left( \frac{R1 + R2 + R3}{R3} \right) \\ R_{\text{TOTAL}} &= R1 + R2 + R3 \end{aligned}$$

Use the following steps to determine values for R1, R2, and R3 of Figure 5.

- 1) Choose a value for  $R_{\text{TOTAL}}$ , the sum of R1, R2, and R3. Because the MAX6846/MAX6847 have very high input impedance,  $R_{\text{TOTAL}}$  can be up to  $500\text{k}\Omega$ .

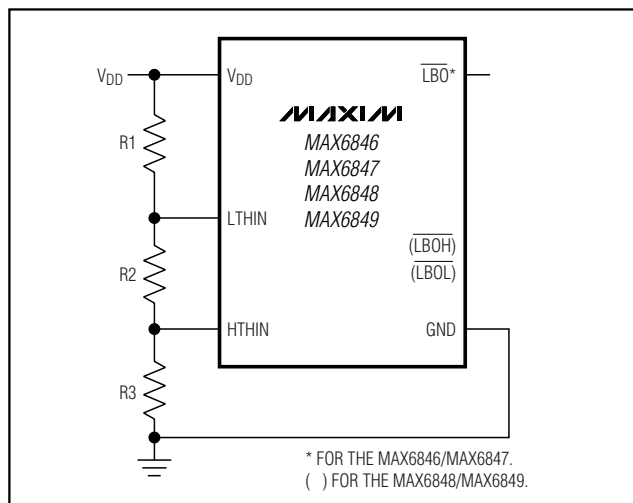


Figure 5. Adjustable Threshold Selection

- 2) Calculate R3 based on  $R_{\text{TOTAL}}$  and the desired upper trip point:

$$R3 = \frac{615\text{mV} \times R_{\text{TOTAL}}}{V_{\text{TRIPHIGH}}}$$

- 3) Calculate R2 based on  $R_{\text{TOTAL}}$ , R3, and the desired lower trip point:

$$R2 = \left( \frac{615\text{mV} \times R_{\text{TOTAL}}}{V_{\text{TRIPLOW}}} \right) - R3$$

- 4) Calculate R1 based on  $R_{\text{TOTAL}}$ , R3, and R2:

$$R1 = R_{\text{TOTAL}} - R2 - R3$$

#### MAX6848/MAX6849

$$V_{\text{LTH-}} = V_{\text{HTH-}} = 582\text{mV}$$

$\overline{\text{LBOL}}$  low-trip level:

$$V_{\text{TRIPLOW}} = V_{\text{LTH-}} \times \left( \frac{R1 + R2 + R3}{R2 + R3} \right)$$

$\overline{\text{LBOH}}$  low-trip level:

$$V_{\text{TRIPHIGH}} = V_{\text{HTH-}} \times \left( \frac{R1 + R2 + R3}{R3} \right)$$

$$R_{\text{TOTAL}} = R1 + R2 + R3$$

Use the following steps to determine values for R1, R2, and R3 of Figure 5.

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu P$ Reset

- 1) Choose a value for  $R_{TOTAL}$ , the sum of  $R1$ ,  $R2$ , and  $R3$ . Because the MAX6848/MAX6849 have very high input impedance,  $R_{TOTAL}$  can be up to 500k $\Omega$ .
- 2) Calculate  $R3$  based on  $R_{TOTAL}$  and the desired upper trip point:

$$R3 = \frac{582mV \times R_{TOTAL}}{V_{TRIPHIGH}}$$

- 3) Calculate  $R2$  based on  $R_{TOTAL}$ ,  $R3$ , and the desired lower trip point:

$$R2 = \left( \frac{582mV \times R_{TOTAL}}{V_{TRIPLOW}} \right) - R3$$

- 4) Calculate  $R1$  based on  $R_{TOTAL}$ ,  $R3$ , and  $R2$ :

$$R1 = R_{TOTAL} - R2 - R3$$

- 5)  $\overline{LBOL}$  high-trip level:

$$V_{TRIPLOW} \times 1.05$$

- 6)  $\overline{LBOH}$  high-trip level:

$$V_{TRIPHIGH} \times 1.05$$

## Monitoring Multicell Battery Applications

For monitoring multicell Li+ (or a higher number of alkaline/NiCd/NiMH cells), connect  $V_{DD}$  to a supply voltage between 1.6V to 5.5V. Figure 6 shows  $V_{DD}$  connected directly to  $V_{CC}$ . To calculate the values of  $R1$ ,  $R2$ , and  $R3$ , see the *Resistor-Value Selection* section.

## DC-DC Converter Application

The MAX6848/MAX6849 dual battery monitors can be used in conjunction with a DC-DC converter to power microprocessor systems using a single Li+ cell or two

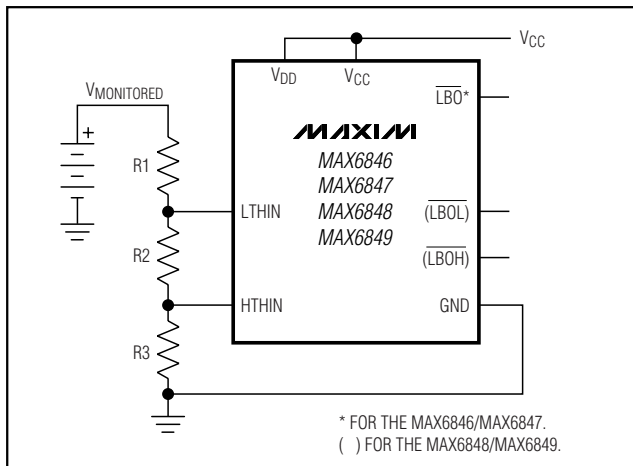


Figure 6. Monitoring Multicell Li+ Applications

to three alkaline/NiCd/NiMH cells. The  $\overline{LBOH}$  output indicates that the battery voltage is weak, and is used to warn the microprocessor of potential problems. Armed with this information, the microprocessor can reduce system power consumption. The  $\overline{LBOL}$  output indicates the battery is empty and system power should be disabled. By connecting  $\overline{LBOL}$  to the SHDN pin of the DC-DC converter, power to the microprocessor is removed. Microprocessor power does not return until the battery has recharged to a voltage greater than  $V_{LTH+}$  (see Figure 7).

Table 1. Factory-Trimmed VCC Reset Threshold Levels

PART NO. SUFFIX ( )	VCC NOMINAL RESET THRESHOLD (V)
T	3.075
S	2.925
R	2.625
Z	2.313
Y	2.188
W	1.665
V	1.575

Table 2. VCC Reset Timeout Period Suffix Guide

TIMEOUT PERIOD SUFFIX	ACTIVE TIMEOUT PERIOD (ms)	
	MIN	MAX
D3	150	300
D7	1200	2400

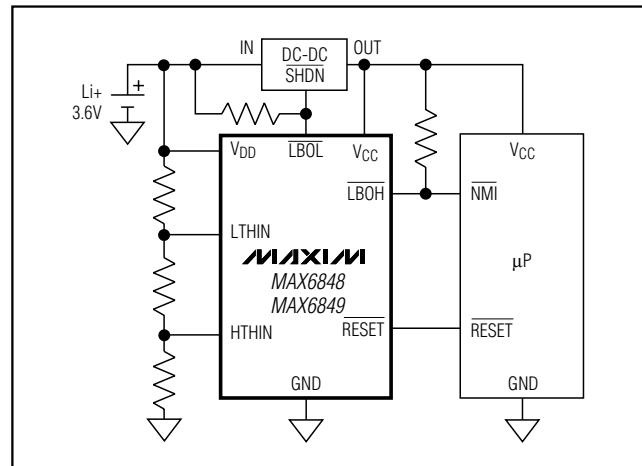


Figure 7. DC-DC Converter Application

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

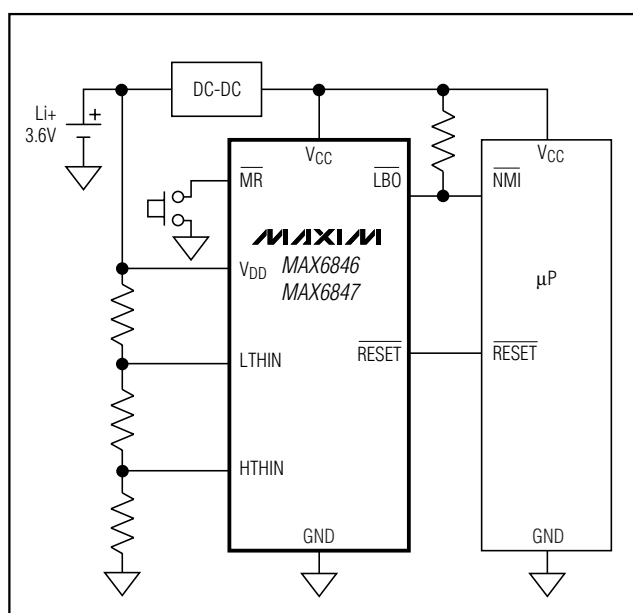
## Selector Guide

PART	OPEN-DRAIN $\overline{\text{RESET}}$	PUSH-PULL $\overline{\text{RESET}}$	SINGLE LOW- BATTERY OUTPUT	DUAL LOW-BATTERY OUTPUT
MAX6846	X	—	X	—
MAX6847	—	X	X	—
MAX6848	X	—	—	X
MAX6849	—	X	—	X

## Standard Versions Table

PART	TOP MARK
MAX6846KARD3	AEJI
MAX6846KASD3	AEJD
MAX6846KAWD3	AEJK
MAX6846KAZD3	AEJJ
MAX6847KARD3	AEJE
MAX6847KASD3	AEJL
MAX6847KAWD3	AEJN
MAX6847KAZD3	AEJM
MAX6848KARD3	AEJP
MAX6848KASD3	AEJO
MAX6848KAWD3	AEJR
MAX6848KAZD3	AEJQ
MAX6849KARD3	AEJT
MAX6849KASD3	AEJS
MAX6849KAWD3	AEJV
MAX6849KAZD3	AEJU

## Typical Application Circuit



## Chip Information

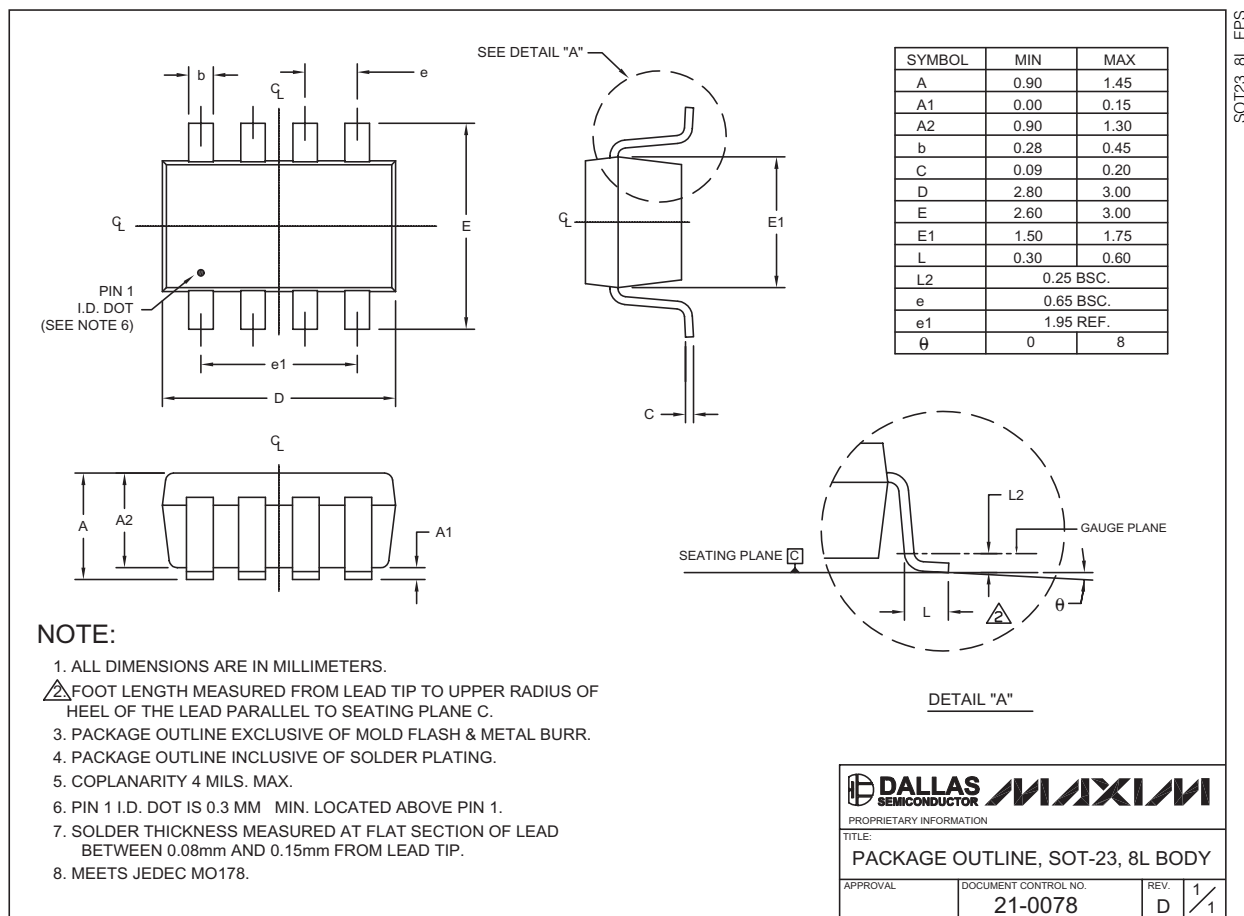
TRANSISTOR COUNT: 1478

PROCESS: BiCMOS

# Low-Power, Adjustable Battery Monitors with Hysteresis and Integrated $\mu$ P Reset

## Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information go to [www.maxim-ic.com/packages](http://www.maxim-ic.com/packages).)



SOT23, 8L, EPS

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